Mean dE/dx with electron_phi40_diag_z860

$\frac{\sigma}{\mu}$(XP) = 8.27 ± 0.11 %

$\frac{\sigma}{\mu}$(WF$_{clus}$) = 8.21 ± 0.11 %
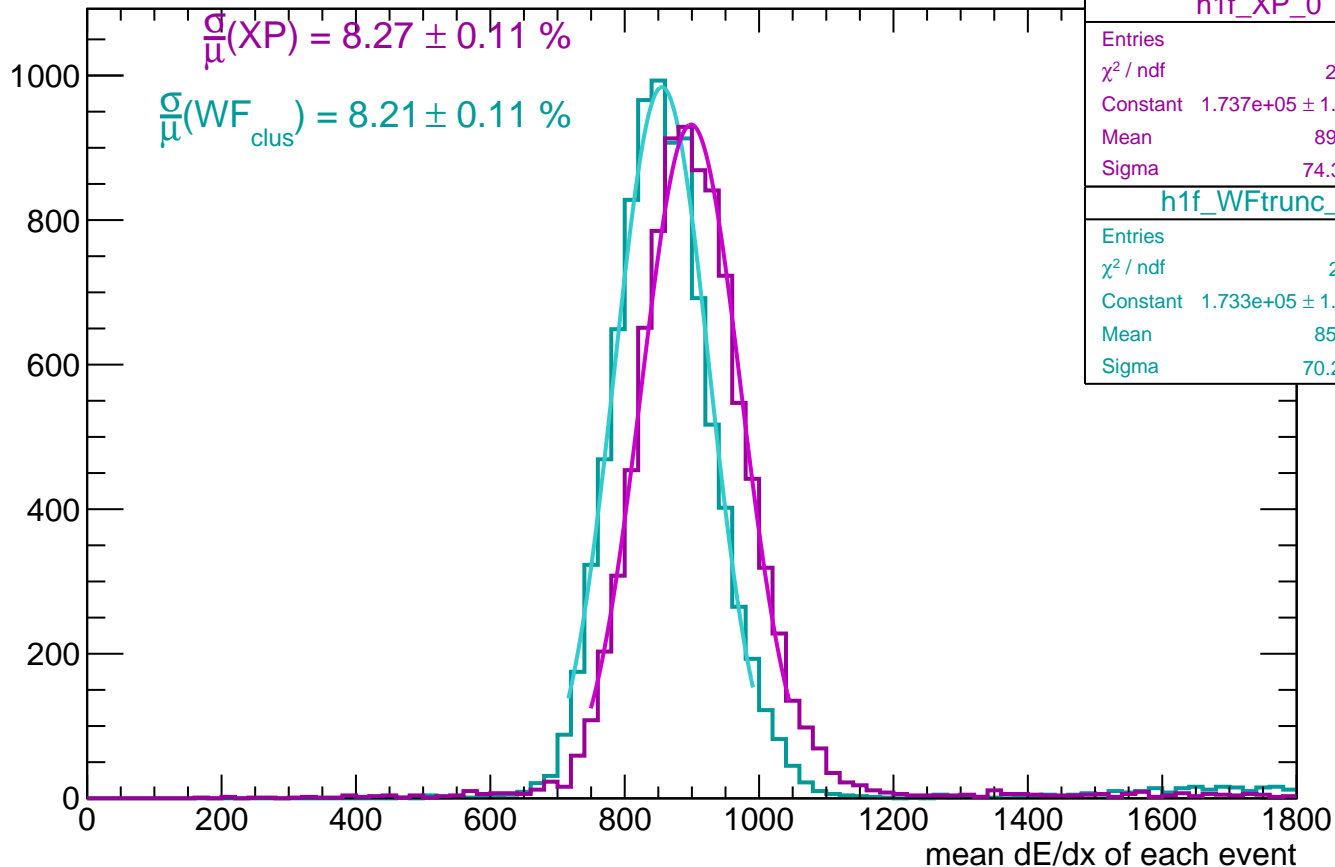
h1f_XP_0	
Entries	9088
χ^2 / ndf	22.28 / 12
Constant	1.737e+05 ± 1.966e+03
Mean	898.8 ± 0.9
Sigma	74.32 ± 0.90

h1f_WFtrunc_0	
Entries	9088
χ^2 / ndf	24.61 / 11
Constant	1.733e+05 ± 1.976e+03
Mean	855.4 ± 0.9
Sigma	70.27 ± 0.88

Counts

mean dE/dx of each event

XP vs WF$_{cluster}$ <dE/dx> (selected data, module 0)

h2f_XPvsWF_0		
Entries		0
Mean x		0
Mean y		0
Std Dev x		0
Std Dev y		0
0	0	0
0	0	0
0	0	0

WF$_{cluster}$ <dE/dx> (ADC count)

XP <dE/dx> (ADC count)

WF$_{\text{not trunc}}$ - WF$_{\text{trunc}}$ vs WF$_{\text{not trunc}}$ (module 0)

Y-axis: WF$_{\text{not trunc}}$ - WF$_{\text{trunc}}$ <dE/dx> (ADC count)

X-axis: WF$_{\text{not trunc}}$ <dE/dx> (ADC count)

h2f_WFmWFvsWF_0		
Entries		0
Mean x		0
Mean y		0
Std Dev x		0
Std Dev y		0
0	0	0
0	0	0
0	0	0